Se	Search Notes			

 Application/Control No.	Applicant(s)/Patent under Reexamination
10/672,095	CHOI ET AL.
Examiner	Art Unit
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	SEARCHED			
Class	Subclass	Date	Examiner	
455	566	8/8/2007	PP	
455	74	8/8/2007	PP	
455	567	8/8/2007	PP	
348	207.1	8/8/2007	PP	
348	333.02	8/8/2007	PP	
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## 0A # #				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
On East [US-PGPUB, USPA, USOCR, EPO, JPO, DERWENT, IBM_TDB] SEE SEARCH TERMS ATTACHED]	8/8/2007	PP
Inventor Name Search	8/8/2007	PP